

## Notice of References Cited

Application/Control No.	Applicant(s)/Pate	nt Under
09/989,577	Reexamination OKUNO ET AL.	
Examiner	 Art Unit	
Brian S Kwon	1614	Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
	Α,	US-6,416,964 b2	07-2002	Reszka et al.	435/15	
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## FOREIGN PATENT DOCUMENTS

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